


<b>Search Notes</b>  	<b>Application/Control No.</b>  10539366	<b>Applicant(s)/Patent Under Reexamination</b>  TIEKE ET AL.
	<b>Examiner</b>  ANEETA PATANKAR	<b>Art Unit</b>  4134

SEARCHED			
Class	Subclass	Date	Examiner
369	59.11, 59.12	4/2/2008	AVP
East			

SEARCH NOTES		
Search Notes	Date	Examiner
East	4/2/2008	AVP
Inventor Search	4/3/2008	AVP
Consulted with Joseph Haley	4/2/2008	AVP
Consulted with Wayne Young	4/2/2008	AVP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner